



# **FCC&IC RF Test Report**

**Product Name: HSDPA Module**

**Model Number: MU509-c**

**Report No: SYBH(Z-RF)001112012-2001  
Class II Permissive Change of FCC ID:QISMU509C  
Class II Permissive Change of IC: 6369A-MU509C**

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## Notice

1. The laboratory has obtained the accreditation of China National Accreditation Service for Conformity Assessment (CNAS), and accreditation number: L0310.
2. The laboratory has been listed on the US Federal Communications Commission list of test facilities recognized to perform electromagnetic emissions measurements. The site recognition number is 97456.
3. The laboratory has been listed by industry Canada to perform electromagnetic emission measurement. The site recognition number is 6369A-2.
4. The test report is invalid if not marked with "exclusive stamp for the test report".
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7. If there is any dissidence for the test report, please file objection to the test centre within 15 days from the date of receiving the test report.
8. Normally, the test report is only responsible for the samples that have undergone the test.
9. Context of the test report cannot be used partially or in full for publicity and/or promotional purposes without previous written approval of the laboratory.



<b>Applicant:</b>	Huawei Technologies Co., Ltd.
<b>Address:</b>	Administration Building, Headquarters of Huawei Technologies Co., Ltd., Bantian, Longgang District, Shenzhen, 518129, P.R.C
<b>Date of Receipt Test Item:</b>	Nov.14, 2012
<b>Start Date of Test:</b>	Nov.15, 2012
<b>End Date of Test:</b>	Nov.15, 2012
<b>Test Result:</b>	Pass

Approved By Senior Engineer Nov.15, 2012 Dai Linjun  
 Date Name Signature

Reviewed By Nov.15, 2012 Cousy Xu  
 Date Name Signature

Operated By Nov.15, 2012 Huang Qiuliang  
 Date Name Signature



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# 1 General Information

<b>1.1 Applied Standard</b>	
Applied Rules:	47 CFR FCC Part 2:2011, Subpart J 47 CFR FCC Part 22:2011, Subpart H ANSI/TIA 603C:2004 RSS-Gen Issue 3 RSS-132 Issue 2
<b>1.2 Test Location</b>	
Test Location 1:	Reliability Laboratory of Huawei Technologies Co., Ltd.
Address:	Administration Building, Headquarters of Huawei Technologies Co., Ltd., Bantian, Longgang District, Shenzhen, 518129, P.R.C
<b>1.3 Test Environmental Condition</b>	
Ambient Temperature:	20 – 25 °C
Ambient Relative Humidity:	45 – 55 %
Atmospheric Pressure:	101 kPa



## 2 Summary

Table 1 Summary of results

Test Case	FCC Part No.	Requirements	Result
Cellular Band			
Transmitter Output Power	2.1046 & 22.913	ERP not exceed 7 W	Pass
Modulation Characteristics	2.1047	Digital modulation	NT
Occupied Bandwidth	2.1049	(Not specified)	NT
Band Edges Compliance	2.1051 & 22.917	Below -13 dBm/1%*EBW, in 1 MHz range	NT
Spurious Emission at Antenna Terminals	2.1051 & 22.917	Below -13 dBm/1 kHz, 9 kHz to 150 kHz Below -13 dBm/10 kHz, 150 kHz to 30 MHz Below -13 dBm/100 kHz, 30 MHz to 10 <sup>th</sup> harmonics	NT
Field Strength of Spurious Radiation	2.1053 & 22.917	Below -13 dBm/100 kHz	Pass
Frequency Stability	2.1055 & 22.355	Maintained within the tolerances of $\pm 2.5$ ppm	NT

Table 2 Summary of results

Test Case	IC Standard No.	Requirements	Result
Cellular Band			
Transmitter Output Power	RSS-Gen, §4.8; RSS-132, §4.4	EIRP not exceed 11.5 W	Pass
Modulation Characteristics	RSS-132, §4.2	Digital modulation	NT
Occupied Bandwidth	RSS-Gen, §4.6	(Not specified)	NT
Band Edges Compliance	RSS-Gen, §4.9; RSS-132, §4.5	Below -13 dBm/1%*EBW, in 1 MHz range	NT
Spurious Emission at Antenna Terminals	RSS-Gen, §4.9; RSS-132, §4.5	Below -33 dBm/1 kHz, 9 kHz to 150 kHz Below -23 dBm/10 kHz, 150 kHz to 30 MHz Below -13 dBm/100 kHz (EBW $\leq$ 4 MHz), 30 MHz to 5 <sup>th</sup> harmonics Below -43 dBm/1 kHz, 9 kHz to 150 kHz Below -33 dBm/10 kHz, 150 kHz to 30 MHz Below -13 dBm/1 MHz (EBW > 4 MHz), 30 MHz to 5 <sup>th</sup> harmonics	NT
Field Strength of Spurious Radiation	RSS-Gen, §4.9; RSS-132, §4.5	Below -13 dBm/100 kHz (EBW $\leq$ 4 MHz) Below -13 dBm/1 MHz (EBW > 4 MHz)	Pass
Frequency Stability	RSS-Gen, §4.7; RSS-132, §4.3	Maintained within the tolerances of $\pm 1.5$ ppm	NT
Receiver Spurious Emissions (Conducted)	RSS-Gen, §4.10; RSS-Gen, §6; RSS-132, §4.6	Below 2 nW/4 kHz (-57 dBm/4 kHz), for 30 MHz - 1000 MHz Below 5 nW/MHz (-53 dBm/MHz), for above 1 GHz	Pass

NTTE: Only Delta test cases = pass, other test cases refer to SYBHZ(R)E005112010EB-2

### 3 Product Description

#### 3.1 Product Information

##### 3.1.1 General Description

MU509-c Module is subscriber equipment in the GSM/UMTS system. The frequency band of this report is 850M. The MU509-c implements such functions as RF signal receiving / Transmitting, HSDPA/WCDMA/EDGE/GPRS/GSM protocol processing and data service etc. Externally it provides LGA interface. It has not an internal antenna. MU509-c uses Qualcomm QSC6270 chipset and Zero-IF technologies.

##### 3.1.2 Board Information

Table 3 Board Information

HSDPA Module		
MU509-c		
Board and Module		
Model name	Serial Number	Remarks
MU509-c	4CA2A110A1900056	QSC6270

##### 3.1.3 Power Source

DC voltage nominal:	 3.8V; Supplied by LGA interface
DC voltage range	 3.3-4.2V
DC current maximal:	1A



### 3.1.4 Applied DC Voltages and Currents

According to CFR (FCC) part 2, subpart 2, section 2.1033(c) (8).

The voltage and current in the final RF stage is:

Table 4 Applied RF Module DC Voltages and Currents

Voltage:	 2.85V (for the RF IC)
Current:	150mA According to CFR (FCC) part 2, subpart 2, section 2.1033(c) (8)
Voltage:	 3.6V (for the PA module)
Current:	350mA According to CFR (FCC) part 2, subpart 2, section 2.1033(c) (8)



## 4 Test Description

### 4.1 Supported Frequency Range

Characteristics	Description
Downlink	869 to 894 MHz
Uplink	824 to 849 MHz

### 4.2 Transmitter / Receiver Characteristics

Characteristics	Description
System Type	GSM UMTS
TX Output Power (per Antenna Port)	GSM system: 33dBm UMTS system: 23.5dBm
Channel Spacing(s) / Bandwidth(s)	GSM system: 200 kHz UMTS system: 5 MHz
Designation of Emissions	GSM system: 247KGXW (GMSK modulation), 249KG7W (8PSK modulation) UMTS system: 4M19F9W

### 4.3 Antenna Gain

Antenna Gain(dBi)	4.28
Antenna Gain(dBd)	2.13

## 5 General Test Conditions / Configurations

### 5.1 RF Channels under Test

Test Mode	TX / RX	RF Channel		
		Low (L)	Middle (M)	High (H)
TM1/TM2	TX	Channel 128	Channel 192	Channel 251
		824.2MHz	837.0MHz	848.8MHz
	RX	Channel 128	Channel 192	Channel 251
		869.2MHz	882.0MHz	893.8MHz
TM3/TM4	TX	Channel 4132	Channel 4182	Channel 4233
		826.4MHz	836.4MHz	846.6MHz
	RX	Channel 4357	Channel 4407	Channel 4458
		871.4MHz	881.4MHz	891.6MHz

### 5.2 Test Modes

Test Mode	Test Modes Description
TM1	GSM/GPRS, GMSK modulation
TM2	EDGE, 8PSK modulation
TM3	WCDMA, QPSK modulation
TM4	HSDPA, QPSK modulation

### 5.3 Test Environment

Environment Parameter	Selected Values During Tests	
Relative Humidity	Ambient	
Temperature	TN	Ambient
Voltage	VL	3.3V
	VN	3.8V
	VH	4.2V

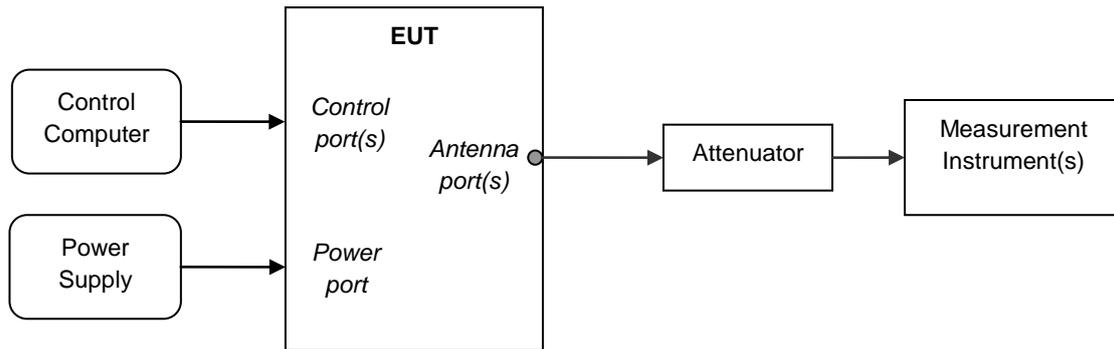
NOTE: VL= lower extreme test voltage  
 VN= nominal voltage  
 VH= upper extreme test voltage  
 TN= normal temperature

## 5.4 Test Setup

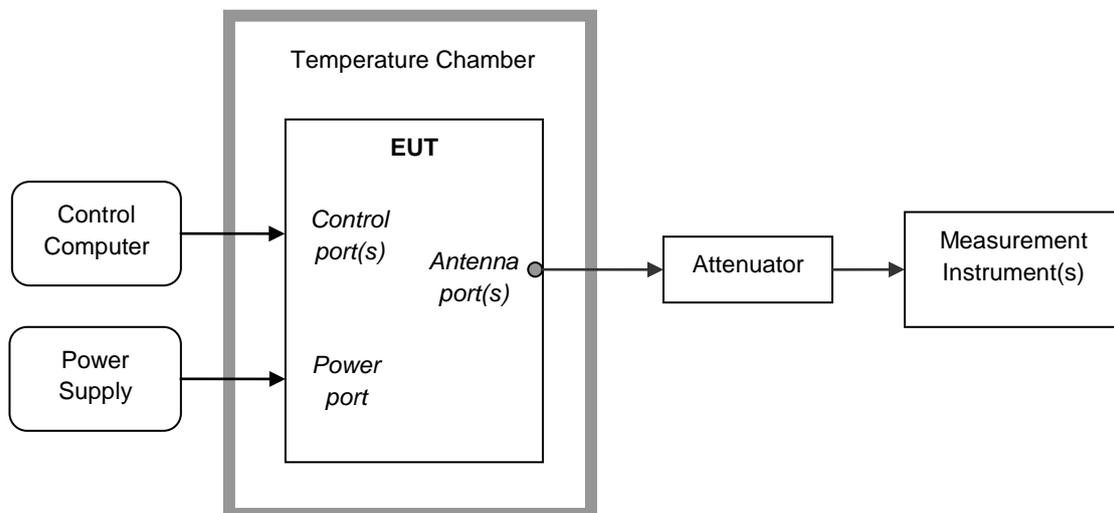
### 5.4.1 General Test Setup Configurations

Configuration	Description
Test Antenna Ports	Until otherwise declared, all TX tests are ONLY performed at the main Transmitter antenna port (e.g. TRXA, TXA and so on) of the EUT, and all RX tests are ONLY performed at the main Receiver antenna port (e.g. TRXA, RXA and so on) of the EUT.
Multiple RF Sources	Other than the tested RF source of the EUT, other RF source(s) are disabled or shutdown during measurements.

### 5.4.2 Test Setup 1



### 5.4.3 Test Setup 2



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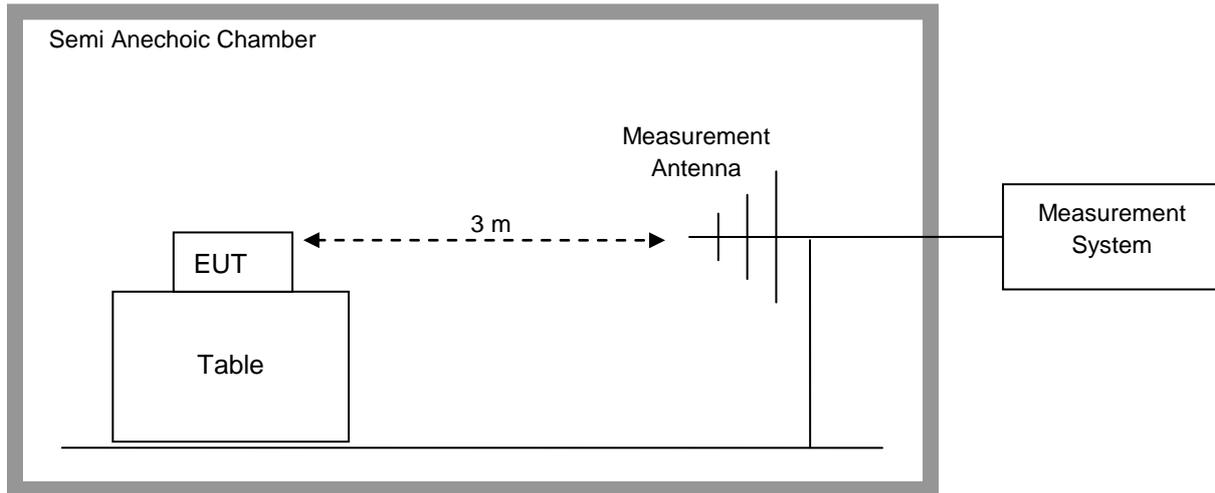
#### 5.4.4 Test Setup 3

NOTE1: Effective radiated power (ERP) or Effective Isotropic radiated power (EIRP) refers to the EUT radiation power output, assuming all emissions are radiated from half-wave dipole antennas or horn antennas.

NOTE2: The EUT was set on insulator 80cm above the Ground Plane. The setup and test methods were according to ANSI-TIA-603C 2004. The measurements were carried through with a Rohde and Schwarz Test Receiver and control software.

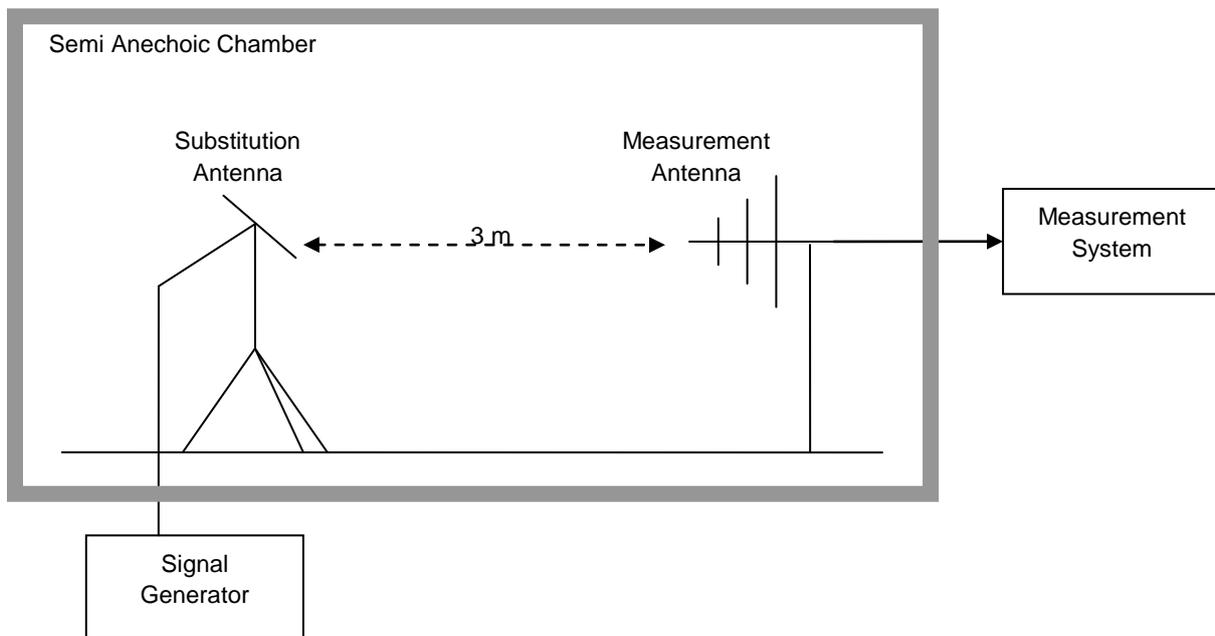
#### Step 1: Pre-test to find the Maximum ERP or EIRP

1. Connect the test system according to the following figure. EUT is running for 30 minutes before test, and measurement instruments are warming-up for 30 minutes.
2. Set up communication link between Universal radio communication tester and EUT, set EUT working frequency, and control EUT to transmit at maximum power.
3. Set the center frequency of the signal analyzer or receiver to the EUT's operating frequency, the RBW is equal to the emission bandwidth of the signal. Set RMS detector for the test, and the span is equal to 2 times of emission bandwidth, the other settings should remain automatic. Normally, the height range of antenna was 1m to 4m, the azimuth range of turntable was 0° to 360°. The receiver antenna has two polarizations V and H. A portable or small unlicensed wireless device shall be placed on a non-metallic test fixture or other non-metallic support during testing. The supporting fixture shall permit orientation of the EUT in each of three orthogonal (x, y, z) axis positions such that emissions from the EUT are maximized. Measure the EUT maximum RF power and record the result.
4. Changing EUT working frequency and measuring the RF power at channel T, M, B respectively.  
Complete the test data.



## Step 2: Substitution method to verify the maximum ERP or EIRP

1. Measurement setup is according to the following figure. EUT was substituted by antenna, and the polarization is identical with the test antenna; the signal generator was connected to the substitution antenna.
2. The radiated output power, measured by signal analyzer set, is the same as recorded in above. Then this power level is matched by a signal from a calibrated signal generator which is substituted for EUT. The power supplied by the generator is then equal to the ERP or EIRP after corrected by the antenna gain and cable loss.



## 5.5 Test Conditions

Test Case	Test Conditions	
Transmitter Output Power	Test Configuration	Ambient Temperature & Rated Voltage
	Test Setup	Test Setup 1 & Test Setup 3
	Detector	RMS
	RF Channels (TX)	L, M, H
	Test Mode	TM1/TM2/TM3/TM4
Modulation Characteristics	Test Configuration	Ambient Temperature & Rated Voltage
	Test Setup	Test Setup 1
	RF Channels (TX)	M
	Test Mode	TM1/TM2/TM3
Occupied Bandwidth	Test Configuration	Ambient Temperature & Rated Voltage
	Test Setup	Test Setup 1
	Detector	PK
	RF Channels (TX)	L, M, H
	Test Mode	TM1/TM2/TM3
Band Edges Compliance	Test Configuration	Ambient Temperature & Rated Voltage
	Test Setup	Test Setup 1
	Detector	RMS
	RF Channels (TX)	L, H
	Test Mode	TM1/TM2/TM3
Spurious Emission at Antenna Terminals	Test Configuration	Ambient Temperature & Rated Voltage
	Test Setup	Test Setup 1
	Detector	PK
	RF Channels (TX)	L, M, H
	Test Mode	TM1/TM2/TM3
Field Strength of Spurious Radiation	Test Configuration	Ambient Temperature & Rated Voltage
	Test Setup	Test Setup 3
	Detector	PK
	RF Channels (TX)	M
	Test Mode	TM1/TM2/TM3/TM4
Frequency Stability	Test Configuration	(1) -30 °C to +50 °C with step 10 °C at Rated Voltage; (2) 85%, 100% and 115% of Rated Voltage at Ambient Temperature.
	Test Setup	Test Setup 2
	RF Channels (TX)	M



Test Case	Test Conditions	
	Test Mode	TM1/TM2/TM3
Receiver Spurious Emissions	Test Configuration	Ambient Temperature & Rated Voltage
	Test Setup	Test Setup 3
	Detector	PK
	RF Channels (TX)	M
	Test Mode	TM1/TM2/TM3/TM4

## 6 Main Test Instruments

Table 5 Main Test Equipments

Equipment Description	Manufacturer	Model	Serial Number	Calibrated until
Power supply	KEITHLEY	2303	1288003	Sept., 27,2013
Universal Radio Communication Tester	R&S	CMU200	117341	Jan., 12,2013
Universal Radio Communication Tester	Agilent	E5515C	MY50260239	Aug., 30,2013
Spectrum analyzer	Agilent	E4440A	MY49420179	Jul., 17,2013
Signal analyzer	R&S	FSQ31	200021	Sept., 27,2013
Temperature chamber	WEISS	WKL64	24600294	Feb.,13,2013
Signal generator	Agilent	E8257D	MY49281095	Jul.,09,2013
Spectrum analyzer	R&S	FSU3	200474	Mar., 05, 2013
Spectrum analyzer	R&S	FSU43	100144	Mar., 05, 2013
Double-Ridged Waveguide Horn Antenna (1G~18GHz)	R&S	HF907	100304	Apr., 05, 2013
Double-Ridged Waveguide Horn Antenna (1G~18GHz)	R&S	HF907	100391	Apr., 05, 2013
Trilog Broadband Antenna (30M~3GHz)	SCHWARZBECK	VULB 9163	9163-521	Jul., 07, 2013
Pyramidal Horn Antenna(26GHz-40GHz)	ETS-Lindgren	3160-10	00123940	Feb., 27, 2013
Pyramidal Horn Antenna(18GHz-26.5GHz)	ETS-Lindgren	3160-09	00125912	Feb., 27, 2013

Table 6 Note: All the equipments are calibrated once a year. When it's almost due, we will arrange calibration again before the calibration deadline.



## 7 Test Results

No.	Test Item	Test Result
1	Transmitter Output Power	Appendix A
2	Modulation Characteristics	Appendix B
3	Occupied Bandwidth	Appendix C
4	Band Edges Compliance	Appendix D
5	Spurious Emission at Antenna Terminals	Appendix E
6	Field Strength of Spurious Radiation	Appendix F
7	Frequency Stability	Appendix G
8	Receiver Spurious Emissions	Appendix H
9	Photos of Test Setup	Appendix I

NOTE1: There is no test data in Appendix H, only Photos of Test Setup for Field Strength of Spurious Radiation.

NOTE2: Only Transmitter Output Power and Field Strength of Spurious Radiation have been tested

## 8 Measurement Uncertainty

For a 95% confidence level (k=2), the measurement expanded uncertainties for defined systems, in accordance with the recommendations of ISO 17025 as following:

Test Item		Extended Uncertainty
Transmitter Output Power	Power (dBm)	U =0.39 dB
Occupied Bandwidth	Magnitude (%)	U=0.2%
Band Edge Compliance	Disturbance Power (dBm)	U=2.0 dB
Conducted Spurious Emissions	Disturbance Power (dBm)	U=2.0 dB
Field Strength of Spurious Radiation	ERP (dBm)	U=4.6 dB (30 MHz – 1GHz) U=3.0 dB (above 1 GHz)
Frequency Stability	Frequency Accuracy (ppm)	U=0.21 ppm

-----The END-----